Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,398	MEISEL ET AL.	
Examiner	Art Unit	
Patrick J. Lee	2878	

SEARCHED					
Class	Subclass	Date	Examiner		
250	207, 214VT, 214.1	3/7/2006 8(10/2006 5(23/2006	PL		
313	103CM	(PL		
313 .	105CM		PL .		
313	105R		PL		
348	216.1		PL		
348	217.1	↓	PL		
Updated	search	12/13/2006	PL		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					
1	Interference search attached 12/13/2006		PL		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	8/7/2006	PL
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	8/10/2006	PL
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	8/23/2006	PL
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/13/2006	PL